

Application/Control No.	Applicant(s)/Patent under Reexamination
10/606,801	TSUJITA ET AL.
Examiner	Art Unit
Tioniio Chon	2652

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	SEARCHED					
Class	Subclass	Date	; Examiner			
430	270.11	7/21/2005	. TJ			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Reports	7/21/2005	TJ		
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